

## TC74HC245AP/AF/AFW TC74HC640AP/AF

### Octal Bus Transceiver

#### TC74HC245 3-State, Non-Inverting

#### TC74HC640 3-State, Inverting

The TC74HC245A, and 640A are high speed CMOS OCTAL BUS TRANSCEIVERs fabricated with silicon gate C<sup>2</sup>MOS technology.

They achieve the high speed operation similar to equivalent LSTTL while maintaining the CMOS low power dissipation.

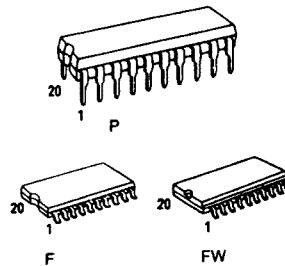
They are intended for two-way asynchronous communication between data busses. The direction of data transmission is determined by the level of the DIR input.

The enable input (G) can be used to disable the device so that the busses are effectively isolated.

All inputs are equipped with protection circuits against static discharge or transient excess voltage.

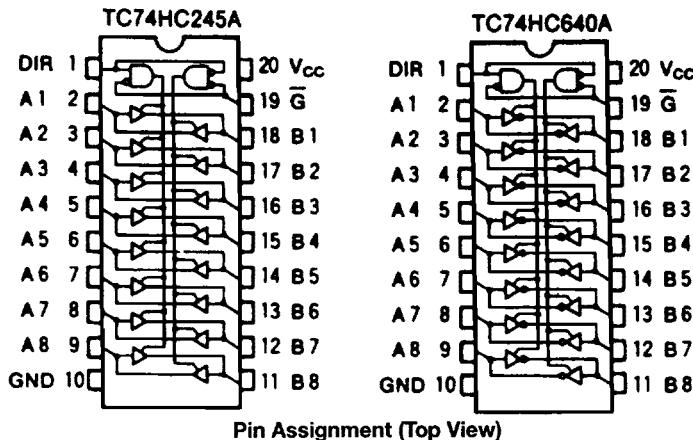
### Features

- High Speed:  $t_{pd} = 10\text{ns}(\text{Typ.})$  at  $V_{CC} = 5\text{V}$
- Low Power Dissipation:  $I_{CC} = 4\mu\text{A}(\text{Max.})$  at  $T_a = 25^\circ\text{C}$
- High Noise Immunity:  $V_{NIH} = V_{NIL} = 28\% V_{CC}$  (Min)
- Output Drive Capability: 15 LSTTL Loads
- Symmetrical Output Impedance:  $|I_{OHI}| = I_{OL} = 6\text{mA}(\text{Min.})$
- Balanced Propagation Delays:  $t_{PLH} = t_{PHL}$
- Wide Operating Voltage Range:  $V_{CC}(\text{opr}) = 2\text{V} \sim 6\text{V}$
- Pin and Function Compatible with 74LS245, 640, 643

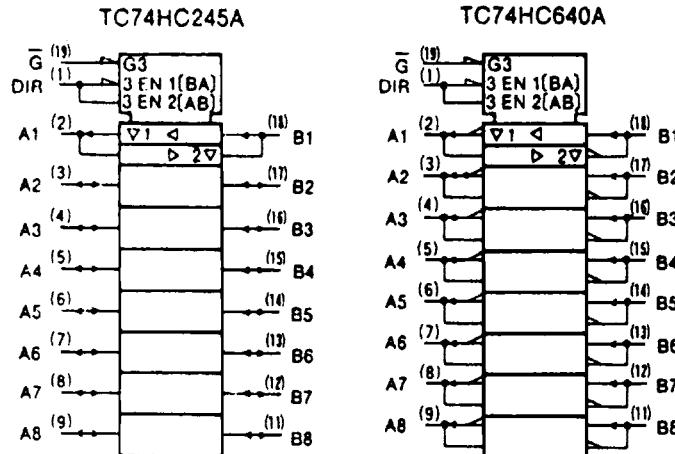


### Application Notes

- 1) Do not apply a signal to any bus terminal when it is in the output mode. Damage may result.
- 2) All floating (high impedance) bus terminals must have their input levels fixed by means of pull up or pull down resistors or bus terminator ICs such as the Toshiba TC40117BP.



Pin Assignment (Top View)



IEC Logic Symbol

Truth Table

Inputs		Function		Outputs	
<b>G</b>	<b>DIR</b>	<b>A Bus</b>	<b>B Bus</b>	<b>HC245A</b>	<b>HC640A</b>
L	L	Output	Input	A = B	A = B
L	H	Input	Output	B = A	B = $\bar{A}$
H	X	High Impedance		Z	Z

X: "H" or "L"

Z: High Impedance

**Absolute Maximum Ratings**

Parameter	Symbol	Value	Unit
Supply Voltage Range	V <sub>CC</sub>	-0.5 ~ 7	V
DC Input Voltage	V <sub>IN</sub>	-0.5 ~ V <sub>CC</sub> + 0.5	V
DC Output Voltage	V <sub>OUT</sub>	-0.5 ~ V <sub>CC</sub> + 0.5	V
Input Diode Current	I <sub>IK</sub>	±20	mA
Output Diode Current	I <sub>OK</sub>	±20	mA
DC Output Current	I <sub>OUT</sub>	±35	mA
DC V <sub>CC</sub> /Ground Current	I <sub>CC</sub>	±75	mA
Power Dissipation	P <sub>D</sub>	500(DIP)*/180(MFP)	mW
Storage Temperature	T <sub>STG</sub>	-65 ~ 150	°C
Lead Temperature 10sec	T <sub>L</sub>	300	°C

\*500mW in the range of Ta = -40°C ~ 65°C. From Ta = 65°C to 85°C a derating factor of -10mW/°C shall be applied until 300mW.

**Recommended Operating Conditions**

Parameter	Symbol	Value	Unit
Supply Voltage	V <sub>CC</sub>	2 ~ 6	V
Input Voltage	V <sub>IN</sub>	0 ~ V <sub>CC</sub>	V
Output Voltage	V <sub>OUT</sub>	0 ~ V <sub>CC</sub>	V
Operating Temperature	T <sub>OPR</sub>	-40 ~ 85	°C
Input Rise and Fall Time	t <sub>r</sub> , t <sub>f</sub>	0 ~ 1000(V <sub>CC</sub> = 2.0V) 0 ~ 500(V <sub>CC</sub> = 4.5V) 0 ~ 400(V <sub>CC</sub> = 6.0V)	ns

**DC Electrical Characteristics**

Parameter	Symbol	Test Condition	Ta = 25°C			Ta = -40 ~ 85°C		Unit	
			V <sub>CC</sub>	Min.	Typ.	Max.	Min.	Max.	
High-Level Input Voltage	V <sub>IH</sub>	—	2.0	1.5	—	—	1.5	—	V
			4.5	3.15	—	—	3.15	—	
			6.0	4.2	—	—	4.2	—	
Low-Level Input Voltage	V <sub>IL</sub>	—	2.0	—	—	0.5	—	0.5	V
			4.5	—	—	1.35	—	1.35	
			6.0	—	—	1.8	—	1.8	
High-Level Output Voltage	V <sub>OH</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OH</sub> = -20μA	2.0	1.9	2.0	—	1.9	V
				4.5	4.4	4.5	—	4.4	
				6.0	5.9	6.0	—	5.9	
			I <sub>OH</sub> = -6 mA	4.5	4.18	4.31	—	4.13	
Low-Level Output Voltage	V <sub>OL</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OH</sub> = -7.8mA	6.0	5.68	5.80	—	5.63	V
			I <sub>OL</sub> = 20μA	2.0	—	0.0	0.1	—	
				4.5	—	0.0	0.1	—	
				6.0	—	0.0	0.1	—	
3-State Output Off-State Current	I <sub>OZ</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub> V <sub>OUT</sub> = V <sub>CC</sub> or GND	I <sub>OL</sub> = 6 mA	4.5	—	0.17	0.26	—	μA
			I <sub>OL</sub> = 7.8mA	6.0	—	0.18	0.26	—	
Input Leakage Current	I <sub>IN</sub>	V <sub>IN</sub> = V <sub>CC</sub> or GND	6.0	—	—	±0.1	—	±1.0	
Quiescent Supply Current	I <sub>CC</sub>	V <sub>IN</sub> = V <sub>CC</sub> or GND	6.0	—	—	4.0	—	40.0	

AC Electrical Characteristics ( $C_L = 50\text{pF}$ , Input  $t_i = t_r = 6\text{ns}$ )

Parameter	Symbol	Test Condition	Ta = 25°C			Ta = -40 ~ 85°C		Unit		
			CL	V <sub>CC</sub>	Min.	Typ.	Max.			
Output Transition Time	$t_{TLH}$ $t_{THL}$	—	50	2.0 4.5 6.0	— — —	25 7 6	60 12 10	— — —	75 15 13	
Propagation Delay Time	$t_{PLH}$ $t_{PHL}$	—	50	2.0 4.5 6.0	— — —	33 12 10	90 18 15	— — —	115 23 20	
				150	2.0 4.5 6.0	— — —	48 16 14	120 24 20	— — —	150 30 26
					2.0 4.5 6.0	— — —	48 16 14	150 30 26	— — —	190 38 32
3-State Output Enable Time	$t_{pzL}$ $t_{pzH}$	$R_L = 1\text{k}\Omega$	50	2.0 4.5 6.0	— — —	48 16 14	150 30 26	— — —	190 38 32	
				150	2.0 4.5 6.0	— — —	63 21 18	180 36 31	— — —	225 45 38
					2.0 4.5 6.0	— — —	37 17 15	150 30 26	— — —	190 38 32
Input Capacitance	C <sub>IN</sub>	DIR, G	—	—	5	10	—	10	pF	
Bus Input Capacitance	C <sub>OUT</sub>	A <sub>n</sub> , B <sub>n</sub>	—	—	13	—	—	—		
Power Dissipation Capacitance	C <sub>PD(1)</sub>	TC74HC245A	—	—	39	—	—	—		
		TC74HC640A	—	—	37	—	—	—		

Note (1) C<sub>PD</sub> is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.  
 Average operating current can be obtained by the equation:

$$I_{CC(\text{opr})} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CO}/8(\text{per bit})$$